## Notice of References Cited Application/Control No. 10/721,979 Applicant(s)/Patent Under Reexamination SHIEH ET AL. Examiner Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,461,906 B1	10-2002	Lung, Hiang-Lan	438/216
	В	US-6,403,494 B1	06-2002	Chu et al.	438/719
·	С	US-6,110,780	08-2000	Yu et al.	438/258
	D	US-			
	Ε	US-			
	F	US-			
	O	US-			
	Η	US-			,
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N				,	
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	х	

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